

Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
MI22-2457PRIORITY SERIAL
NO. 10/735,355LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT: Zhongze Wang

PRIORITY FILING DATE
January 10, 2003PRIORITY GROUP
ART UNIT 2812

U.S. PATENT DOCUMENTS

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
Ju	AA	5,021,843	06/1991	Ohmi			
Ju	AB	5,849,627	12/1998	Linn et al.			
Ju	AC	6,255,731 B1	07/2001	Ohmi et al.			
Ju	AD	6,410,938 B1	06/2002	Xiang			
Ju	AE	6,433,401 B1	08/2002	Clark et al.			
Ju	AF	6,610,615 B1	08/2003	McFadden et al.			
Ju	AG	2002/0134503 A1	02/2002	Hussinger et al.			
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

Ju	AM		Bernstein et al., <i>Floating Body Effects</i> , SOI DEVICE ELECTRICAL PROPERTIES 34-53 (pre-August 2001).
	AN		
	AO		

EXAMINER

DATE CONSIDERED

James M. Kennedy Feb 20 2005

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M22-2457SERIAL NO.
10735,355LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT: Zhongze Wang

FILING DATE
December 12, 2003GROUP ART UNIT
Unassigned

2812

U.S. PATENT DOCUMENTS

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
gm	AA	6,010,921	01/2000	Soutame	438	151	
	AB						
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FOREIGN PATENT DOCUMENTS

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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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James M. Kennedy Feb 20, 2005

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Form PTO 1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2457		SERIAL NO. 10/735,355	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT: Zhongze Wang			
		FILING DATE 12/12/2003		GROUP 2811 2812	

U.S. PATENT DOCUMENTS							
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
QU	AA	6,552,496 B2	04/2003	Yamazaki	315	169.3	
QU	AB	5,882,532	03/1999	Field et al.	216	2	
QU	AC	6,265,327	07/2001	Kobayashi et al.	438	776	
	AD						
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FOREIGN PATENT DOCUMENTS								
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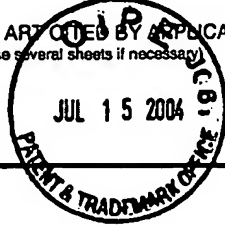
EXAMINER	DATE CONSIDERED
<i>James M. Kennedy</i>	<i>Feb 20, 2005</i>

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12/12/2003GROUP
2812

U.S. PATENT DOCUMENTS

*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
94	AA	6,512,244 B1	01/2003	Ju et al.	257	59	
94	AB	6,509,613 B1	01/2003	En et al.	257	349	
94	AC	6,541,861 B2	04/2003	Higashi et al.	257	751	
94	AD	6,680,243 B1	01/2004	Kamath et al.	438	526	
94	AE	6,531,375 B1	03/2003	Giewont et al.	438	407	
94	AF	6,661,065 B2	12/2003	Kunikiyo	257	411	
94	AG	5,773,355	06/1998	Inoue et al.	438	459	
94	AH	5,767,020	06/1998	Sakaguchi et al.	438	705	
94	AI	6,534,380 B1	03/2003	Yamauchi et al.	438	455	

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Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
94	AA	5,374,329	12/1994	Miyawaki	156	630		
94	AB	2002/0070454 A1	06/2002	Yasukawa	257	760		
94	AC	2002/0011670 A1	01/2002	Higashi et al.	257	751		
94	AD	2001/0020722 A1	09/2001	Yang	257	347		
94	AE	2003/0085424 A1	05/2003	Bryant et al.	257	347		
94	AF	6,313,014 B1	11/2001	Sakaguchi et al.	438	475		
94	AG	6,350,703 B1	02/2002	Sakaguchi et al.	438	766		
94	AH	5,453,394	09/1995	Yonehara et al.	437	62		
94	AI	5,405,802	04/1995	Yamagata et al.	437	71		
FOREIGN PATENT DOCUMENTS								
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94	AA	6,037,634	03/2000	Akiyama	257	347	
94	AB	5,841,171	11/1998	Iwamatsu et al.	257	347	
94	AC	5,910,672	06/1999	Iwamatsu et al.	257	347	
94	AD	5,670,411	09/1997	Yonehara et al.	437	62	
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10735,355

OCT 28 2004

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FILING DATE
December 12, 2003GROUP
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U.S. PATENT DOCUMENTS

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>me</i>	AA	6,215,155	04/2001	Wollesen	257	351	
<i>me</i>	AB	6,268,630	07/2001	Schwank et al.	257	347	
<i>me</i>	AC	6,340,829	01/2002	Hirano et al.	257	347	
<i>me</i>	AD	6,552,396	04/2003	Byrant et al.	257	347	
<i>me</i>	AE	6,642,579	11/2003	Fung	257	347	
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